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L7	405	382/313.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/06/22 10:57
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| <input type="checkbox"/> | <b>2. Frame-rate displacement measurement system utilizing an ultra-high-speed shut an optical correlator</b><br>Toyoda, H.; Kobayashi, Y.; Mukohzaka, N.; Yoshida, N.; Hara, T.; Ohno, T.;<br>Instrumentation and Measurement, IEEE Transactions on<br>Volume 44, Issue 3, June 1995 Page(s):755 - 758<br><a href="#">AbstractPlus</a>   Full Text: <a href="#">PDF</a> (340 KB) <b>IEEE JNL</b>  |
| <input type="checkbox"/> | <b>3. Single camera three-dimensional endoscope system using a ferroelectric liquid c</b><br>Lester, G.A.; Watts, J.; Wilmington, D.;<br>Science, Measurement and Technology, IEE Proceedings-<br>Volume 145, Issue 2, March 1998 Page(s):49 - 51<br><a href="#">AbstractPlus</a>   Full Text: <a href="#">PDF</a> (308 KB) <b>IEE JNL</b>   |
| <input type="checkbox"/> | <b>4. Real-time displacement measurement using a pattern correlation system incorpc high-speed shutter camera and parallel aligned nematic liquid crystal spatial ligh (PAL-SLMs)</b><br>Toyoda, H.; Kobayashi, Y.; Mukohzaka, N.; Yoshida, N.; Hara, T.; Ohno, T.;<br>Instrumentation and Measurement Technology Conference, 1994. IMTC/94. Conferenc<br>10th Anniversary. Advanced Technologies in I & M., 1994 IEEE<br>10-12 May 1994 Page(s):1345 - 1348 vol.3<br><a href="#">AbstractPlus</a>   Full Text: <a href="#">PDF</a> (248 KB) <b>IEEE CNF</b> |
| <input type="checkbox"/> | <b>5. Analysis for Improvement of simultaneity of shuttering in an ultra high-speed fra</b><br>Ito, Y.; Kato, Y.; Kagata, M.; Tomioka, S.; Enoto, T.;<br>Magnetics, IEEE Transactions on<br>Volume 36, Issue 4, July 2000 Page(s):1774 - 1778<br><a href="#">AbstractPlus</a>   <a href="#">References</a>   Full Text: <a href="#">PDF</a> (128 KB) <b>IEEE JNL</b>   |
| <input type="checkbox"/> | <b>6. 3-dimensional personal computer system</b><br>Iwasaki, K.; Karibe, I.; Nakai, K.; Ueno, A.;<br>Consumer Electronics, IEEE Transactions on  |